

**Notice of References Cited**

Application/Control No.

09/818,466

Applicant(s)/Patent Under  
Reexamination  
LEE ET AL.

Examiner

Humera N. Sheikh

Art Unit

1615

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,517,863	02-2003	LaTorre et al.	--
*	B	US-6,224,888	05-2001	Vatter et al.	--
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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*	N	9937287	07-1999	WO	LEE et al.	--
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	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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